

12500 TI Boulevard, MS 8640, Dallas, Texas 75243

Notification# 20170118001 Datasheet for ADS1113, ADS1114, ADS1115 Information Only

Date: February 08, 2017 **To:** PREMIER FARNELL PCN

Dear Customer:

This is an information-only announcement of a change to a device that is currently offered by Texas Instruments.

The changes discussed within this notification are for your information only.

Any negotiated alternative change requirements will be provided via the customer's defined process. Customers with previously negotiated, special requirements will be handled separately. Any inquiries should be directed to your local Field Sales Representative.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (PCN www admin team@list.ti.com).

Sincerely,

PCN Team SC Business Services

Information Only Attachments

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	CUSTOMER PART NUMBER
ADS1113IDGST	null
ADS1114IDGST	null
ADS1114IRUGT	null
ADS1115IDGSR	null
ADS1115IDGST	null

Technical details of this Product Change follow on the next page(s).

PCN Number: 2017011800			118001		PCN Date:	Fe	Feb. 8, 2017		
Title:	Datasheet for	ADS11	13, ADS	1114, ADS	1115				
Custon	ner Contact:	PCN Mar	nager				De	ot:	Quality Services
Change	е Туре:								
Ass	sembly Site			Design				Wafer	Bump Site
Ass	sembly Process		\boxtimes	Data Shee	et			Wafer	Bump Material
Assembly Materials				Part number change				Wafer	Bump Process
Mechanical Specification				Test Site				Wafer	Fab Site
Packing/Shipping/Labeling				Test Process				Wafer	Fab Materials
								Wafer	Fab Process
			No	otificatio	n Details				
Description of Change:									
Texas Instruments Incorporated is announcing an information only notification.									
The product datasheet(s) is being updated as summarized below.									
The following change history provides further details.									

Changes from Revision B (October 2009) to Revision C

Texas Instruments

ADS1113, ADS1114, ADS1115

SBAS444C -MAY 2009-REVISED DECEMBER 2016

С	Changes from Revision B (October 2009) to Revision C		
•	Added Device Information, ESD Ratings, Recommended Operating Conditions, and Thermal Information tables, and Parameter Measurement Information, Detailed Description, Application and Implementation, Power Supply Recommendations, Layout, Device and Documentation Support, and Mechanical, Packaging, and Orderable Information sections	1	
•	Changed Title, and Description, Features, and Applications sections for clarity	1	
•	Deleted temperature range text from Description section and moved to Features section	1	
•	Changed Product Family table title to Device Comparison Table and deleted Package Designator column	4	
•	Changed Pin Functions table for clarity	4	
•	Changed Power-supply voltage max value from 5.5 V to 7 V in Absolute Maximum Ratings table	5	
•	Changed Analog input voltage min value from -0.3 V to GND - 0.3 V in Absolute Maximum Ratings table	5	
•	Changed Digital input voltage min value from −0.5 V to GND − 0.3 V in Absolute Maximum Ratings table	5	
•	Changed Digital input voltage max value from 5.5 V to VDD + 0.3 V in Absolute Maximum Ratings table	5	
•	Deleted Analog input current rows in Absolute Maximum Ratings table	5	
•	Added Input current row in Absolute Maximum Ratings table	5	
•	Added Operating temperature range of -40°C to +125°C back into Absolute Maximum Ratings table	5	
•	Added minimum specification of –40°C for T _J in <i>Absolute Maximum Ratings</i> table	5	
•	Changed Electrical Characteristics table conditions line for clarity	6	
•	Changed all instances of "FS" to "FSR"	6	
•	Deleted FSR from Electrical Characteristics and moved to Recommended Operating Conditions table	6	
•	Added values from Table 2 to Differential input impedance parameter in Electrical Characteristics table	6	
•	Changed Output noise parameter link from "see Typical Characteristics" to "see Noise Performance section" in Electrical Characteristics table	6	
•	Changed Offset error empty min value to -3, and max value from ±3 to 3 for clarity in Electrical Characteristics tab	le 6	

•	Changed V _{IH} parameter max value from 5.5 V to VDD in <i>Electrical Characteristics</i> table	6
•	Changed V _{IL} parameter min value from GND − 0.5 V to GND in <i>Electrical Characteristics</i> table	6
•	Changed Input leakage current parameters from two rows to one row, changed test conditions from $V_{IH} = 5.5V$ and $V_{IL} = \text{GND}$ to $\text{GND} < V_{\text{DIG}} < \text{VDD}$, and changed min value from 10 μA to $-10~\mu\text{A}$ in Electrical Characteristics table	6
•	Changed text in note 1 of <i>Electrical Characteristics</i> table from "In no event should more than VDD + 0.3 V be applied to this device" to "No more than VDD + 0.3 V or 5.5 V (whichever is smaller) must be applied to this device. See Table 3 for more information."	6
•	Deleted Power-supply voltage parameter from Electrical Characteristics and moved to Recommended Operating Conditions table	7
•	Deleted Specified temperature parameter from Electrical Characteristics and moved to Recommended Operating Conditions table	7
•	Deleted Storage temperature parameter from Electrical Characteristics and moved to Absolute Maximum Ratings table	7
•	Added condition statement in Timing Requirements: I ² C table	7
•	Added note 1 to Timing Requirements table	7
•	Changed Figure 22; deleted "Gain = 2/3, 1, 2, 4, 8, or 16"	. 13
•	Added Functional Block Diagrams for ADS1114 and ADS1113	. 13
•	Changed Analog Inputs section to provide LSB size information instead of PGA setting	. 15
•	Changed Full-Scale Input section title to Full-Scale Range (FSR) and LSB Size, and updated section for clarity	. 16
•	Added Voltage Reference and Oscillator sections	. 16
•	Changed Comparator section title to Digital Comparator, and updated section for clarity.	. 16
•	Changed Conversion Ready Pin section for clarity	. 17
•	Changed Register Map section for clarity	. 25
•	Changed Application Information section for clarity	. 29
•	Added Input Protection section	. 30
•	Added Unused Inputs and Outputs section	. 30
•	Changed Aliasing section title to Analog Input Filtering and updated section for clarity	. 31
•	Added Typical Application section	. 34

The datasheet number will be changing.

Device Family	Change From:	Change To:
ADS1113, ADS1114, ADS1115	SBAS444B	SBAS444C

These changes may be reviewed at the datasheet links provided. http://www.ti.com/product/ADS1113

Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this PCN:

None.

Product Affected:

ADS1113IDGSR	ADS1113IDGST	ADS1113IRUGR	ADS1113IRUGT
ADS1114IDGSR	ADS1114IDGST	ADS1114IRUGR	ADS1114IRUGT
ADS1115IDGSR	ADS1115IDGST	ADS1115IRUGR	ADS1115IRUGT

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com